Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/042,230	CHIU ET AL.	
Examiner	Art Unit	
Lewis A. Bullock Jr	2195	

SEARCHED					
Class	Subclass	Date	Examiner		
455	1-899	6/22/2005	LAB		
718	100	6/22/2005	LAB		
		niii .			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u>l.</u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST ACM IEEE	6/22/2005	LAB	
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